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DEPOSIT INFORMATION**Express Mail Label No.: EV 327175278 USDate of Deposit: October 19, 2004

Our Case No.: 10808/163

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:

BARTH, Han-Joachim, et al.

Serial No.: not assigned

Filing Date: October 19, 2004

For: METHOD FOR FABRICATING
THIN METAL-CONTAINING
LAYERS HAVING LOW
ELECTRICAL RESISTANCE

Examiner: not assigned

Group Art Unit No.: not assigned

INFORMATION DISCLOSURE STATEMENTCommissioner for Patents
Alexandria, VA 22313-1450

Dear Sir:

In compliance with the duty of disclosure under 37 C.F.R. § 1.56, it is respectfully requested that this Information Disclosure Statement be entered and the documents listed below and on the attached Form PTO-1449 be considered by the Examiner and made of record. Copies of the listed documents required by 37 C.F.R. § 1.98(a)(2) are enclosed for the convenience of the Examiner.

The references now cited are the following:

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U.S. PATENT DOCUMENTS

DOCUMENT NUMBER Number-Kind Code (if known)	DATE	NAME	CLASS/ SUBCLASS	FILING DATE
3,585,088	6/15/1971	Schwuttke, et al.	148/174	10/18/1968
4,758,533	7/19/1988	Magee, et al.	437/173	9/22/1987
5,290,731	3/1/1994	Sugano, et al.	437/174	3/9/1992
5,405,804	4/11/1995	Yabe	437/773	1/21/1994
US 6,242,808 B1	6/5/2001	Shimizu, et al.	257/762	10/7/1998

FOREIGN PATENT DOCUMENTS

DATE	COUNTRY	CLASS/ SUBCLASS	TRANSLATION YES OR NO
6/16/1987	EPO	H01L 21/20	No
6/26/1991	EPO	H01L 23/532	No
9/28/1992	Japan	H01L 21/3205	No
8/6/1999	Japan	H01L 21/3205	Yes
3/1/2000	EPO	H01L 21/768	No.

OTHER ART – NON PATENT LITERATURE DOCUMENTS

Jiang, Qing-Tang, Tsai, Ming-Hsing and Havemann, R.H., "Line Width Dependence of Copper Resistivity," Proceedings of the 2001 International Interconnect Technology Conf., page 227 (3 pages)

International Search Report for counterpart international application number PCT/DE03/01205 (5 pages).

In accordance with 37 C.F.R. § 1.97(g),(h), this Information Disclosure Statement is not to be construed as a representation that a search has been made and is not to be construed to be an admission that the information cited is, or is considered to be, material to patentability as defined in 37 C.F.R. § 1.56(b).

This Information Disclosure Statement is being filed prior to the receipt of the first Official Action reflecting an examination on the merits and hence is believed to be timely filed in accordance with 37 C.F.R. § 1.97(b). No fees are believed to be due in connection with filing of this Information Disclosure Statement, however, should any fees under 37 C.F.R. §§ 1.16 to 1.21 be deemed necessary for any reason relating to these material, the Commissioner is hereby authorized to deduct said fees from Brinks

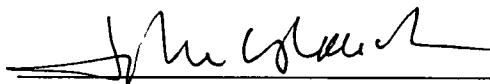
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Hofer Gilson & Lione Deposit Account No. 23-1925. A duplicate copy of this document is enclosed.

In accordance with 37 C.F.R. § 1.97(e)(1), Applicant(s) hereby certify that each item of the information disclosed in this Information Disclosure Statement was cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to filing of the present statement, as evidenced by the date of the enclosed search report.

Applicant(s) respectfully request that the listed documents be made of record in the present case.

Respectfully submitted,


John G. Rauch
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Attorney for Applicant(s)

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FORM PTO-1449	SERIAL NO. not assigned	CASE NO. 10808/163
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT	FILING DATE October 19, 2004	GROUP ART UNIT not assigned
(use several sheets if necessary)	APPLICANT(S): BARTH, Hans-Joachim, et al.	

REFERENCE DESIGNATION **U.S. PATENT DOCUMENTS**

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER <small>Number-Kind Code (if known)</small>	DATE	COUNTRY	CLASS/ SUBCLASS	TRANSLATION YES OR NO
/V.V./	A6	0 225 592 A2	6/16/1987	EPO	H01L 21/20	No
↓	A7	0 434 138 A1	6/26/1991	EPO	H01L 23/532	No
	A8	04271125 A	9/28/1992	Japan	H01L 21/3205	No
↓	A9	11214387 A	8/6/1999	Japan	H01L 21/3205	Yes
/V.V./	A10	0 982 771 B1	3/1/2000	EPO	H01L 21/768	No.

EXAMINER **OTHER ART – NON PATENT LITERATURE DOCUMENTS**

(Include name of author, title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date page(s), volume-issue number(s), publisher, city and/or country where published.)

/V.V./	A11	Jiang, Qing-Tang, Tsai, Ming-Hsing and Havemann, R.H., "Line Width Dependence of Copper Resistivity," Proceedings of the 2001 International Interconnect Technology Conf., page 227 (3 pages)
	A12	International Search Report for counterpart international application number PCT/DE03/01265 (5 pages)

EXAMINER /Vanessa Velasquez/ **DATE CONSIDERED** 01/02/2008

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609;
Draw line through citation if not in conformance and not considered. Include copy of this form with next
communication to applicant.